Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/537,457	HAYAMA ET AL.
Examiner	Art Unit
TUAN A. PHAM	2618

SEARCHED							
Class	Subclass	Date	Examiner				
455	41.2	8/10/2006	PHAM				
	42-44						
	501						
	456.1	8/10/2006	PHAM				

INT	ERFERENC	E SEARCH	ED
Class	Subclass	Date	Examiner
	1.	_	
Ĺ			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
		1		